INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

OIPE JC96 MAR 15 2004 PATENT & TRADEMARK OFFICE

ATTY. DOCKET NO.	SERIAL NO.
50195-391	**10/682,154**
APPLICANT: **Saichirou KANEKO, et al.**	
FILING DATE: **October 10, 2003**	GROUP: **2811**

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes	Translation No
JD		**JP 2002-100773 A**	**04/05/2002**	**TOSHIBA CORP.**		**JAPAN (w/English Abstract**	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER: _____ DATE CONSIDERED: 11/10/04

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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code3-Number 4-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes	Translation No
JD		**JP 10-233503**	**09/02/1998**	**FUJI ELECTRIC CO LTD.**		**JAPAN (w/English Abstract)**	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
JD		**V.V. Afanas'ev, et al. "Observation of Carbon Clusters at the 4H-SIC/SiO_2 Interface." Material Science Forum Vols. 264-268 (1998) pp. 857-860.**
JD		**V.V. Afanasev, et al. " Intrinsic SIC/SiO_2 Interface States." Phys. State. Sol. (A) 162 (1997) pp.321-327**

EXAMINER: [signature] DATE CONSIDERED: 11/10/04

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